

Search Notes

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Examiner

Bin Shen

Applicant(s)/Patent under
Reexamination

YAMAOKA ET AL.

Art Unit

1657

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search.	4/24/2007	BS